

N-channel 800 V, 0.95 Ω typ., 5 A MDmesh[™] K5 Power MOSFET in a TO-220 package

Datasheet - production data



Figure 1: Internal schematic diagram



Features

Order code	e V _{DS} R _{DS(on)} max.		ID
STP7LN80K5	800 V	1.15 Ω	5 A

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing	
STP7LN80K5	7LN80K5	TO-220	Tube	

DocID028826 Rev 1

This is information on a product in full production.

Contents

Contents

1	Electric	cal ratings	3
2	Electric	al characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Packag	e information	9
	4.1	TO-220 type A package information	
5	Revisio	on history	12



1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 30	V
Ι _D	Drain current (continuous) at $T_c = 25 \ ^{\circ}C$	5	А
ID	Drain current (continuous) at T _c = 100 °C	3.4	А
I _D ⁽¹⁾	Drain current (pulsed)	20	А
P _{TOT}	Total dissipation at $T_C = 25 \text{ °C}$	85	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/ns
T _{stg}	Storage temperature	55 to 150	°C
Tj	Operating junction temperature	- 55 to 150	C

Notes:

 $\ensuremath{^{(1)}}\ensuremath{\mathsf{Pulse}}$ width limited by safe operating area.

 $^{(2)}I_{SD} \leq 5$ A, di/dt ≤ 100 A/µs; V_DS peak $\leq V_{(BR)DSS},$ V_DD = 400 V

⁽³⁾V_{DS} ≤ 640 V

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	1.47	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	1.5	А
E _{AS}	(Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} ; V_{DD} = 50 V)	200	mJ



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	800			V
	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA
I _{DSS}		$V_{GS} = 0 V, V_{DS} = 800 V,$ $T_{C} = 125 °C$			50	μA
I _{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = ±20 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \ \mu A$	3	4	5	V
$R_{DS(on)}$	Static drain-source on-resistance	V_{GS} = 10 V, I _D = 2.5 A		0.95	1.15	Ω

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance	V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 V	-	270	-	pF
Coss	Output capacitance		-	22	-	pF
C _{rss}	Reverse transfer capacitance		-	0.5	-	рF
$C_{o(er)}^{(1)}$	Equivalent capacitance energy related	$V_{DS} = 0$ to 640 V, $V_{GS} = 0$ V	-	17	-	nC
C _{o(tr)} ⁽²⁾	Equivalent capacitance time related		-	48	-	nC
R _G	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D=0 \text{ A}$	-	7.5	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, I_D = 5 \text{ A}, V_{GS} = 10 \text{ V}$ (see Figure 15: "Test circuit for	-	12	-	nC
Q _{gs}	Gate-source charge		-	2.6	-	nC
Q_gd	Gate-drain charge	gate charge behavior")	-	8.6	-	nC

Table 6: Dynamic

Notes:

 $^{(1)} Energy$ related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

 $^{(2)}$ Time related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
t _{d(on)}	Turn-on delay time	$V_{DD} = 400 \text{ V}, I_D = 2.5 \text{ A},$	-	9.3	-	ns		
tr	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see <i>Figure</i>	-	6.7	-	ns		
t _{d(off)}	Turn-off-delay time	14: "Test circuit for resistive load switching times" and Figure 19:	-	23.6	-	ns		
t _f	Fall time	"Switching time waveform")	-	17.4	-	ns		

Table	7.	Switching	times
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DocID028826 Rev 1

Electrical characteristics

Table 8: Source drain diode								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
I _{SD}	Source-drain current		-		5	А		
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		20	А		
V _{SD} ⁽²⁾	Forward on voltage	I_{SD} = 5 A, V_{GS} = 0 V	-		1.6	V		
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/µs,	-	276		ns		
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load	-	2.13		μC		
I _{RRM}	Reverse recovery current	switching and diode recovery times")	-	15.4		А		
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/µs,	-	402		ns		
Q _{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{\text{j}} = 150 \text{ °C}$ (see Figure 16: "Test circuit for	-	2.79		μC		
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	13.9		А		

Notes:

 $^{(1)}\mbox{Pulse}$ width is limited by safe operating area

 $^{(2)}\text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30		-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.











Electrical characteristics







57

DocID028826 Rev 1

3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.











Package information

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Table 10: TO-220 type A mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
А	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
øP	3.75		3.85	
Q	2.65		2.95	



Revision history 5

Table 11: Document revision history

Date	Revision	Changes
08-Jan-2016	1	First release.



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